

Description

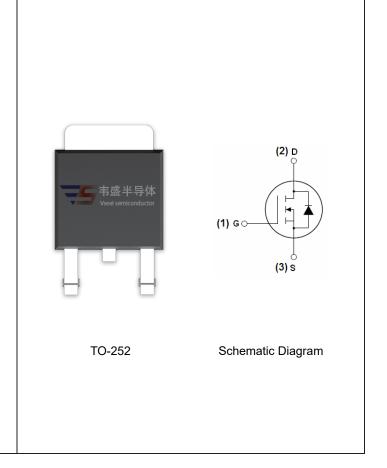
The VSM5N20 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

- V_{DS} =200V, I_D =8A $R_{DS(ON)}$ <300m Ω @ V_{GS} =10V (Typ: 260m Ω)
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Low gate to drain charge to reduce switching losses

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM5N20-T2	VSM5N20	TO-252	-	-	-

Absolute Maximum Ratings (T_c=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	200	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous	I _D	8	А	
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	5.6	А	
Pulsed Drain Current	I _{DM}	20	А	
Maximum Power Dissipation	P _D	55	W	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	°C	

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	$R_{ heta JC}$	2.3	°C/W



Electrical Characteristics (T_C=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			•			
Drain-Source Breakdown Voltage	BV _{DSS}	BV _{DSS} V _{GS} =0V I _D =250μA		215	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =200V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1	1.7	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4.5A	-	260	300	mΩ
Forward Transconductance	g _{FS}	V _{DS} =25V,I _D =4.5A	3	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C _{lss}			540		PF
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V, F=1.0MHz		90		PF
Reverse Transfer Capacitance	C _{rss}	r-1.0IVIHZ		35		PF
Switching Characteristics (Note 4)	·					
Turn-on Delay Time	t _{d(on)}		-	6.4	-	nS
Turn-on Rise Time	t _r	V_{DD} =100 V , I_{D} =4.5 A	-	11	-	nS
Turn-Off Delay Time	t _{d(off)}	$V_{GS}\text{=}10V, R_{GEN}\text{=}5\Omega$	-	20	-	nS
Turn-Off Fall Time	t _f		-	12	-	nS
Total Gate Charge	Qg	\/ 400\/ L 4.55	-	16	-	nC
Gate-Source Charge	Q _{gs}	V_{DS} =160V, I_{D} =4.5A, V_{GS} =10V	-	3.4	-	nC
Gate-Drain Charge	Q _{gd}	VGS-1UV	-	5.1	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =8A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	8	Α

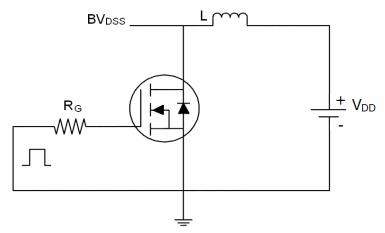
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production

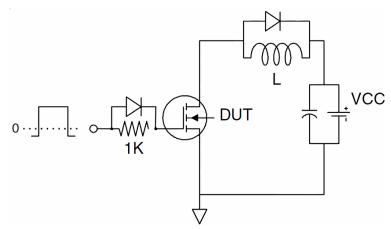


Test Circuit

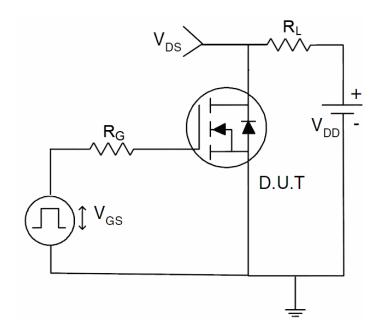
1) E_{AS} test Circuit



2) Gate charge test Circuit

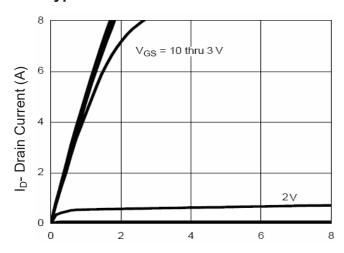


3) Switch Time Test Circuit



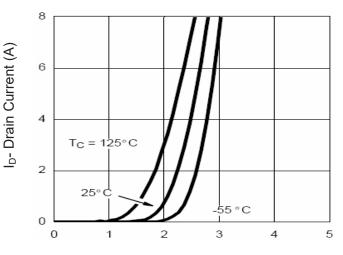


Typical Electrical and Thermal Characteristics (Curves)

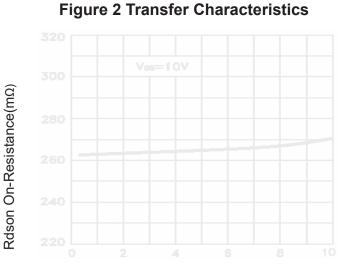


Vds Drain-Source Voltage (V)

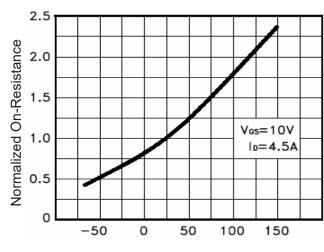




Vgs Gate-Source Voltage (V)



I_D- Drain Current (A) **Figure 3 Rdson- Drain Current**



 T_J -Junction Temperature($^{\circ}\mathbb{C}$)

Figure 4 Rdson-JunctionTemperature

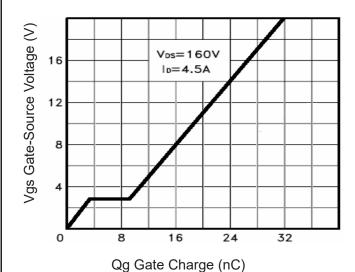


Figure 5 Gate Charge

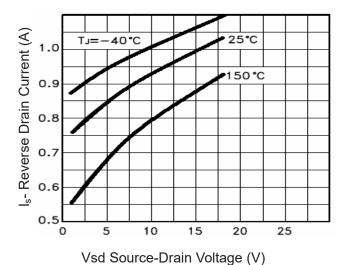
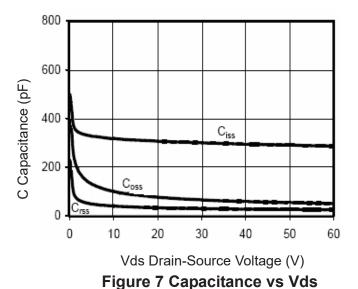


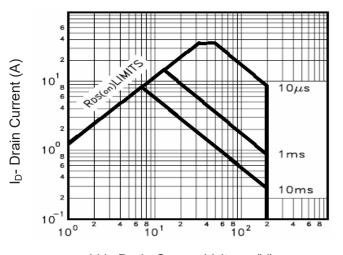
Figure 6 Source- Drain Diode Forward



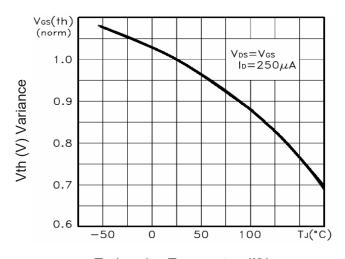


T_J-Junction Temperature(°C)

Figure 9 BV_{DSS} vs Junction Temperature

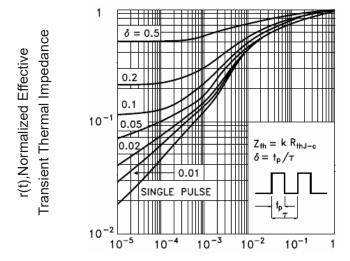






T_J-Junction Temperature(°ℂ)

Figure 10 V_{GS(th)} vs Junction Temperature



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance